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Improving polymer solar cell performances by manipulating the self-organization of polymer

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We have investigated driving force effects on the ordering of polymer, which is a key factor of self-assembly of soft materials. By turning the substrate up-side-down, the downward driving force can form in solution film-growth process and affect the self-organization of polymer chains and domains. We introduce Brown’s capillarity theory [J. Polym. Sci., Polym. Phys. Ed. 22, 423 (1956)] to describe the film formation. Our results show that the better chain and lamellae packing of polymer make hole transport, carrier balance, and power conversion efficiency of annealed and unanneled devices improve even with thick active-layers as compared to conventional devices. © 2011 American Institute of Physics. [doi:10.1063/1.3599488]

Bulk-heterojunction polymer solar cells (PSCs) have attracted considerable attention for its remarkable advantages.¹,² Meanwhile, the solution based film-growth dynamics (the slow growth) of polymer blends has become one of the crucial processes which modifies the polymer morphology to improve the efficiency from bulk-heterojunction structures.³,⁴ The slow growth will assist the formation of self-organized ordered structures in poly(3-hexylthiophene) (P3HT):[6,6]-phenyl C61-butyric acid methyl ester (PCBM) blend system. The electrical and optical properties of polymer blends will also be modified by solution parameters and spin-coating conditions.³,⁴

In this work, we will study driving force effects on the order and phase of crystallization of the blended polymer in solution based self-assembly, which is a key factor of the self-assembly of soft materials⁵ but has been neglected in studying PSC morphology. We investigate driving force effects by flipping the substrate up-side-down (hereafter named as “up-side-down” method) after spin-coating the wet polymer blend.

PSCs with a structure of Indium tin oxide (ITO)/Poly(3,4-ethylenedioxythiophene) poly (styrenesulfonate) (PEDOT:PSS) (Baytron AI4083)/P3HT:PCBM/LiF/Al were fabricated following the method as described elsewhere.⁶ The mixed solution (P3HT:PCBM=1:1, 45 mg/ml) was spin-coated at 800 rpm and 500 rpm for 45 s, forming films with thicknesses of 210 nm and 300 nm respectively. Then the film was quickly transferred to a petri dish for the slow growth for 40 min. The up-side-down film was made by flipping the substrate and letting the wet film face downward during the slow growth. After the slow growth process, the film was annealed at 120 °C for 10 min on a hot plate. Then 1 nm thick of LiF and 100 nm Al were evaporated. Besides fabricating the set of annealed devices stated above, we made a set of unannealed devices and films with film thickness 210 nm for analyzing the effects of forces on the film properties since the annealing afterward will reconstruct polymer morphology.⁷–⁹

To show and analyze the effects of the driving force on PSCs, we first study unannealed devices. By flipping the substrate to make solution film growth, the short circuit current (Jsc) enhances from 6.56 mA/cm² (control) to 7.96 mA/cm² (up-side-down) and the fill factor (FF) improves from 0.47 (control) to 0.6 (up-side-down) as shown in Fig. 1(a). As a result, we obtain PCE of 2.64% for the up-side-down device as compared to 1.69% of the unannealed control device. Meanwhile, from the dark current as shown in Fig. 1(b), we find that the current density of the up-side-down devices is higher than the conventional one particularly at a forward bias, which indicates a higher charge transport in the up-side-down devices.

To analyze the charge transport, we fabricate unanneled hole-only devices with structures of ITO/PEDOT:PSS/P3HT:PCBM (up-side-down and conventional)/Au (20 nm)/Al (60 nm) and ITO/Ca (2 nm) / P3HT:PCBM (up-side-down and conventional)/Au (20 nm)/Al (60 nm) and unanneled electron-only devices of ITO/Ca (2 nm)/P3HT:PCBM (up-side-down and conventional)/LiF (1 nm)/Al (60 nm).¹⁰ As shown in Figs. 1(c) and 1(d), the current density of the up-side-down hole-only device is higher than that of the conventional one. This indicates a better hole transport for the up-side-down device. Meanwhile, the current density of the up-side-down electron-only device is lower than that of the conventional one. Consequently, the increase in hole current density and the decrease in electron current density will make the hole and electron transport more balance as compared to the conventional device for enhancing their performances.

The effects of the up-side-down method on optical properties of polymer blends are illustrated in Fig. 2(a). The absorption spectrum of the up-side-down film shows higher

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light absorption and shaper peak at 600 nm than that of the conventional device due to the improvement of the inter-chain packing of P3HT and local order inside the domains.\textsuperscript{11} Incident-photon-to-electron conversion efficiency (IPCE) also improves as the absorption spectrum shown in Fig. 2\textsuperscript{b}. The maximum IPCE peak of the up-side-down device is 49% at \(600\, \text{nm}\) while the conventional one is 42% at \(560\, \text{nm}\).

The driving force effects on the morphology formation are studied. According to capillarity theory first proposed by Brown, the polymer film formation from solvent is mainly driven by capillary forces \(F_c\) which derives from the surface tension of the interstitial solvent.\textsuperscript{12,13} For the conventional film, the driving force of \(F_c\) points upward as shown in Fig. 2\textsuperscript{i}. The top interface between polymer and air is subject to \(F_c\), which makes the polymer start packing from top and crystallize downward. However, in the blend system, the presence of PCBM could also separate out and block the continuous crystallization of P3HT and new nuclei of P3HT therefore form in the blend layer during the solvent evaporation. As a result, the polymer crystallization at different directions happens at various positions, which agrees with atomic force microscopy (AFM) results as discussed later.

For the up-side-down film, the growth process is different from that of the conventional process, which could make the film better ordered. Initially, crystallization is not favor at the interface like the conventional one since the downward solution due to gravity would dissolve the polymer at the surface again. Meanwhile, when the solvent evaporates, nuclei start to crystallize in the wet polymer layer. Until the solvent reaches a critical volume, the capillarity force plays a dominant role in the film formation process.\textsuperscript{13} At that time, the crystals in the polymer layer continuously grow and pack orderly by the downward driving force of \(F_c\), as indicated from AFM results shown in Fig. 3.

The morphology of polymer blends is investigated by AFM as shown in Figs. 3\textsuperscript{a} and 3\textsuperscript{b}. The surface roughness indicates the ordering of polymer self-organization.\textsuperscript{3} For our devices, the conventional film has an rms roughness of \(6.94\, \text{nm}\) while the up-side-down film has a larger rms roughness of \(9.98\, \text{nm}\) implying a higher ordering structure formed in the up-side-down film. The up-side-down film also has wider waviness (\(\sim 60\, \text{nm}\)) and smoother surface when the conventional one has waviness of \(37\, \text{nm}\) and a lot of small humps. The small humps of the conventional film could be due to the disordered packing of polymer crystals grown in different directions as described above. Consequently, the up-side-down process makes the film has a better polymer ordering and smoother surface which agrees with the previous description of the polymer crystallization.

Figures 3\textsuperscript{c} and 3\textsuperscript{d} show the two-dimensional (2D) GIXRD patterns and Fig. 3\textsuperscript{e} shows the one-dimensional (1D) out-of-plane x-ray profiles of P3HT:PCBM blend measured at Shanghai Synchrotron Radiation Facility.\textsuperscript{14} The intense reflections of (00h) are obtained from 1D out-of-plane
x-ray profiles, which indicated a well organized intraplane structure with lamellae oriented normal to the substrate. The peak maximum of the scattering vector $q_z$ is at 0.391 Å$^{-1}$ corresponding to an interlayer spacing of about 16.1 Å. The film made by the up-side-down method has the same interlayer spacing as that of the conventional method. However, the intensity of the (001) signal of the polymer film made by the up-side-down method is slightly weaker than that of the conventional one, indicating a little smaller size or number of the P3HT crystals formed in up-side-down film. It should be noted that the GIXRD signal is from no more than 10 nm deep from the polymer/air interface. That means for the conventional film, the amount of crystallization at surface is deep from the polymer/air surface. That means for the conventional film and up-side-down film, and 2D GIXRD patterns of (c) conventional film and (d) up-side-down film. (e) is the 1D out of plane of GIXRD result at 00P direction; conventional (black) and up-side-down (red) film. All films are nonannealed and prepared by the slow growth method.

For annealed PSCs, both up-side-down and conventional devices with a typical thickness of about 210 nm show improved performances by thermal annealing. Our results show that PCE of up-side-down devices is still higher than that of conventional devices, i.e., 3.5% compared to 3.3% as shown in Fig. 4. When we increase the active layer to 300 nm, the conventional device performance degrades, due to the increase in recombination of excitons in the thick active layer, $J_{sc}$ reduces to 8.04 mA/cm$^2$ and PCE reduces to 2.55%. Interestingly, $J_{sc}$ of the up-side-down device is further improved from 9.21 to 10 mA/cm$^2$ and PCE achieves 3.58%, which can be explained by the better charge transport paths.

In summary, by controlling the driving force in the solution-film growth dynamics through the up-side-down method, the ordering of polymer blends is improved. We introduce Brown’s capillarity theory to explain the blended polymer film formation. Our results show that the hole transport, carrier balance, $J_{sc}$, and FF improve, and thus PCE enhances in up-side-down devices due to the better chain packing and local order of polymer domains.

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![FIG. 4. (Color online) J-V characteristics of annealed PSCs with different thicknesses. Inset shows the performances of PSCs. For each type of PSCs, 12 devices were made and characterized. Their performances were shown as error bars.](#)